



ALPHA & OMEGA
SEMICONDUCTOR

AO4413A P-Channel Enhancement Mode Field Effect Transistor



General Description

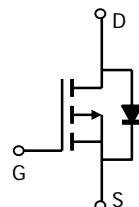
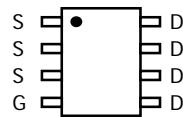
The AO4413A uses advanced trench technology to provide excellent $R_{DS(ON)}$, and ultra-low low gate charge with a 25V gate rating. This device is suitable for use as a load switch or in PWM applications.

Standard product AO4413A is Pb-free (meets ROHS & Sony 259 specifications). AO4413AL is a Green Product ordering option. AO4413A and AO4413AL are electrically identical.

Features

V_{DS} (V) = -30V
 I_D = -15A (V_{GS} = -10V)
 $R_{DS(ON)} < 7m\Omega$ (V_{GS} = -20V)
 $R_{DS(ON)} < 8.5m\Omega$ (V_{GS} = -10V)

SOIC-8
Top View



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 25	V
Continuous Drain Current ^A	I_D	-15	A
$T_A=70^\circ C$		-12.8	
Pulsed Drain Current ^B	I_{DM}	-80	
Power Dissipation ^A	P_D	3	W
$T_A=70^\circ C$		2.1	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	32	40	°C/W
Steady-State		62	75	°C/W
Maximum Junction-to-Lead ^C	$R_{\theta JL}$	18	24	°C/W

Electrical Characteristics ($T_j=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=-250\mu\text{A}, V_{GS}=0\text{V}$	-30			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-24\text{V}, V_{GS}=0\text{V}$ $T_j=55^\circ\text{C}$			-1 -5	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm25\text{V}$			±100	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-1.5	-2.2	-3.5	V
$I_{\text{D(ON)}}$	On state drain current	$V_{GS}=-10\text{V}, V_{DS}=-5\text{V}$	-60			A
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=-20\text{V}, I_D=-15\text{A}$ $T_j=125^\circ\text{C}$		5.5	7	$\text{m}\Omega$
		$V_{GS}=-10\text{V}, I_D=-15\text{A}$		6.6	8.5	$\text{m}\Omega$
		$V_{GS}=-6\text{V}, I_D=-10\text{A}$		8.2		$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{DS}=-5\text{V}, I_D=-15\text{A}$		48		S
V_{SD}	Diode Forward Voltage	$I_S=-1\text{A}, V_{GS}=0\text{V}$		-0.72	-1	V
I_S	Maximum Body-Diode Continuous Current				5	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=-15\text{V}, f=1\text{MHz}$		4245	5500	pF
C_{oss}	Output Capacitance			983		pF
C_{rss}	Reverse Transfer Capacitance			689		pF
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		12	18	Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	$V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, I_D=-15\text{A}$		69	90	nC
Q_{gs}	Gate Source Charge			15.2		nC
Q_{gd}	Gate Drain Charge			18.8		nC
$t_{\text{D(on)}}$	Turn-On DelayTime	$V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, R_L=1.0\Omega, R_{\text{GEN}}=3\Omega$		16.5		ns
t_r	Turn-On Rise Time			23.5		ns
$t_{\text{D(off)}}$	Turn-Off DelayTime			116		ns
t_f	Turn-Off Fall Time			82		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=-15\text{A}, dI/dt=100\text{A}/\mu\text{s}$		59	77	ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=-15\text{A}, dI/dt=100\text{A}/\mu\text{s}$		55		nC

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $\leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6, 12, 14 are obtained using 80 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

F. Rev 0: July 2005

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

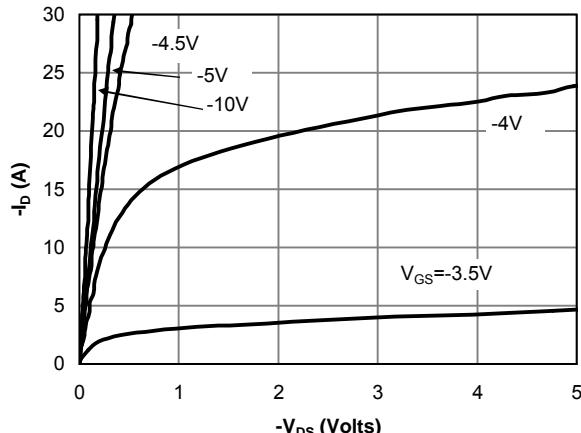


Fig 1: On-Region Characteristics

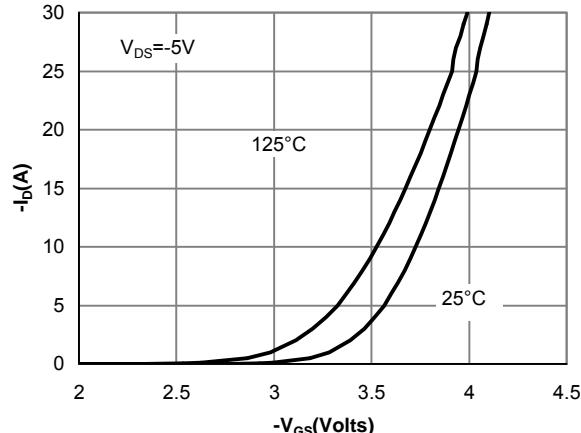


Figure 2: Transfer Characteristics

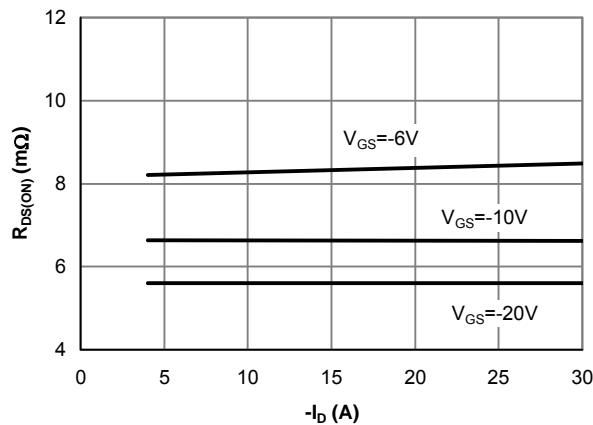


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

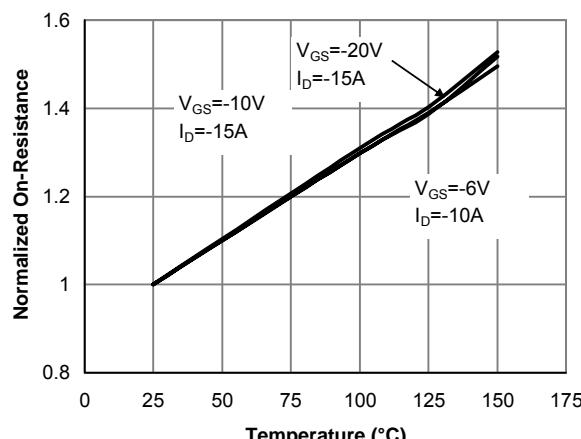


Figure 4: On-Resistance vs. Junction Temperature

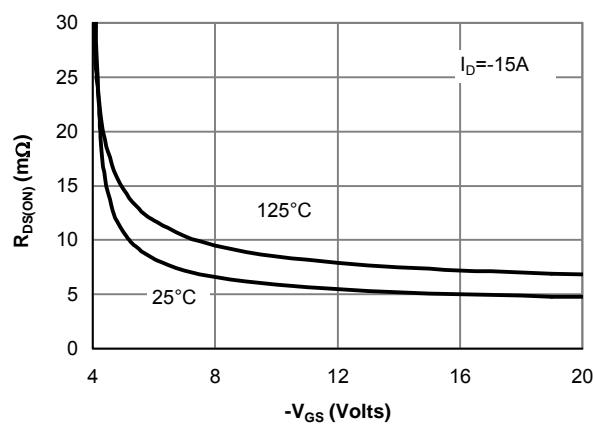


Figure 5: On-Resistance vs. Gate-Source Voltage

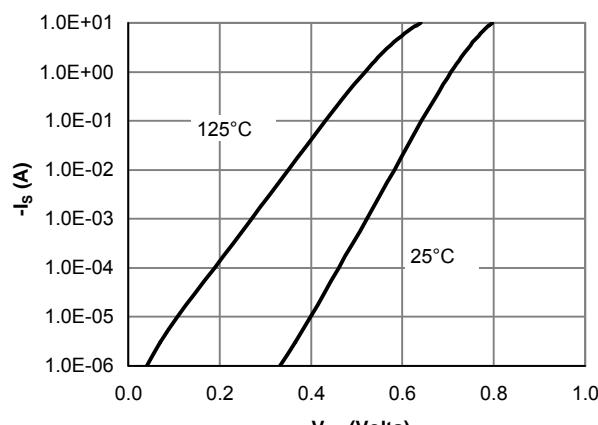


Figure 6: Body-Diode Characteristics

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